

LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>	ATTY DOCKET NO.	SERIAL NO.
	100325.0208US	10/555079
	APPLICANT	
	John Mak et al.	
	FILING DATE	GROUP
	10/27/2005	Unknown

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NN		
EXAMINER	/William Doerrler/	DATE CONSIDERED

04/10/2009

*EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

2081/100325-0208US
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PAGE 5/5 * RCVD AT 1/26/2006 6:54:58 PM [Eastern Standard Time] * SVR:USPTO-EXRF-6/29 * DNI:2738300 * CSID:714 546 9035 * DURATION (mm:ss):02:02

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /WD/